

<b>Notice of References Cited</b>	Application/Control No. 10/743,816	Applicant(s)/Patent Under Reexamination SAI ET AL.	
	Examiner Victor R. Kostak	Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,157,481 A	10-1992	Kashimura et al.	348/263
*	B	US-2002/0047908 A1	04-2002	Mise et al.	348/222
*	C	US-4,733,300	03-1988	Sugiyama et al.	348/448
*	D	US-6,677,994 B1	01-2004	Kobayashi, Atsushi	348/252
*	E	US-5,880,767 A	03-1999	Liu, Samson J.	347/251
*	F	US-5,920,357 a	07-1999	Ohara, Kazuhiro	348/625
*	G	US-2002/0067862	06-2002	Kim, Yeong-Taeg	382/266
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09083958 A	03-1997	Japan	TAKATORI et al.	H04N 7/015
	O	JP 07184169 A	07-1995	Japan	MIYOSHI, TOSHIHIRO	H04H 5/937
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.